

aarv_test

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1 Autonomously Adjusting Reference Voltage Tests

The purpose of autonomously adjusting reference voltage (AARV) is to mitigate rapid voltage change (RVC), without affecting the utility's control of steady-state voltage or the DER's steady-state reactive power. AARV may be used with a volt-watt function that mitigates steady-state overvoltage, but otherwise AARV does not regulate steady-state voltage.

1.1 Code Samples

There are Python code cells in this notebook that create plots and text outputs to illustrate various points of application, implementation, and testing. A live version of this notebook is available at [gridhub](#), under an open-source license and copyright that permit reuse and modification. Run the following Python code cell to define support functions using [Numpy](#) and [Matplotlib](#).

1.2 AARV Test from 1547.1-2020

Clause 5.14.5 of IEEE 1547.1-2020 describes a specific test for AARV. In all other tests, AARV is to be disabled. Four AARV tests are described, at the time constant values $T_{ref} = 300\text{s}$ and 5000s , each of those with source voltage steps to $(V1+V2)/2$ and $(V3+V4)/2$. Before each voltage step, the steady-state reactive power, Q , should be zero at $V=V_{ref}$. The volt-var characteristic $V1..V4$ and $Q1..Q4$ points are set to the default values.

The voltage steps result in step changes of Q to $0.5*Q1$ and $0.5*Q4$, respectively, with some delay from the open-loop response. These new Q values should follow an exponential decay back to zero, governed by $T_{ref} = 300\text{s}$ or 5000s . The test criteria specifies that after one time constant, T_{ref} , the value of Q should be less than 10% of $Q1$ or $Q4$, respectively. However, this behavior depends on whether the volt-var characteristic includes a deadband.

T_{ref} is defined as the time constant for AARV reference voltage. On the other hand, $T_{response}$ is defined as an open-loop response time, which is converted to an exponential time constant in the Python code below. Furthermore, the simulation is run at a constant time step, dt , so both time constants may be implemented as constant decrement factors. If the real hardware controller operates at a constant sample interval, it may also use constant decrement factors to save the time of repeatedly evaluating the exponential functions.

Passing this test verifies implementation of T_{ref} , but not the impact of AARV on a system with grid impedance.

1.2.1 Simulation of AARV Tests

Run the following Python code cell to define a function that simulates and plots an AARV test. The input parameters are:

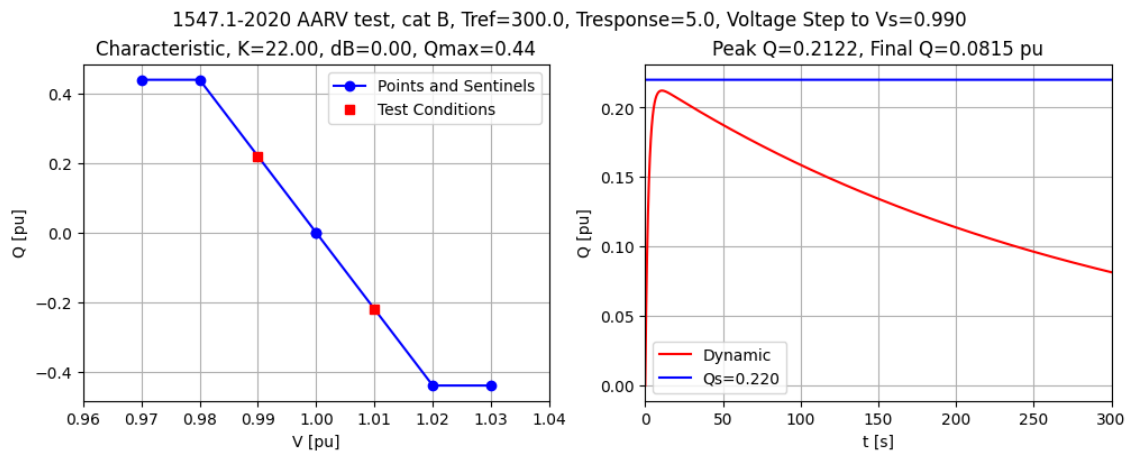
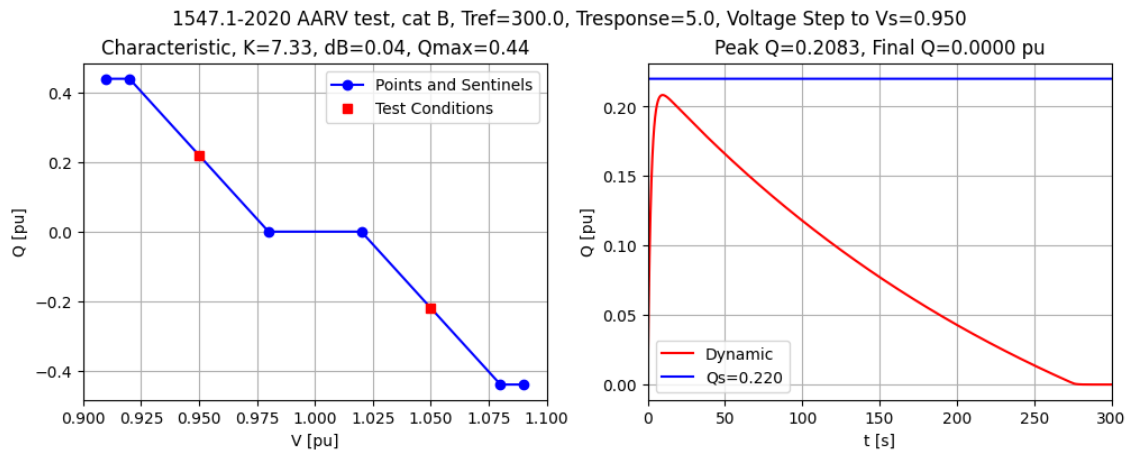
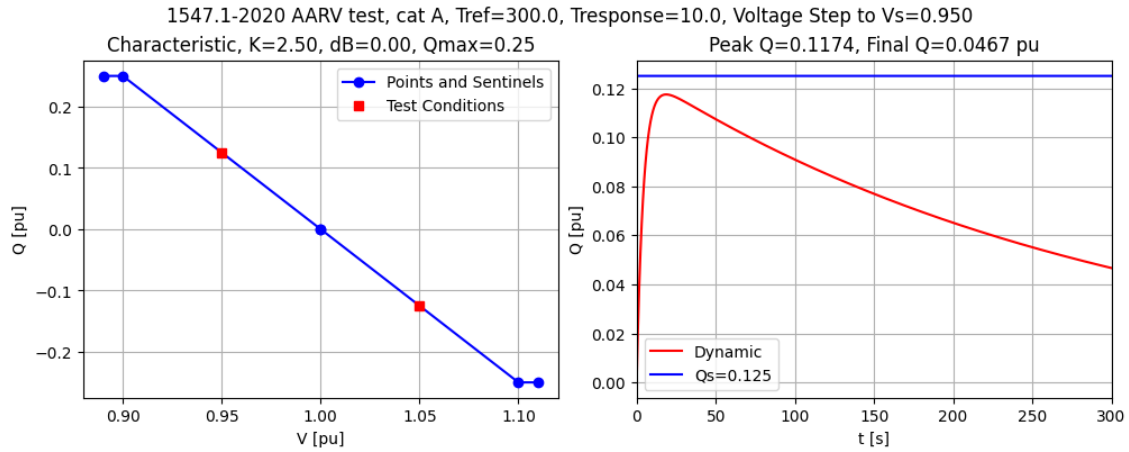
- *tag* is a text label to appear in the plot.
- *Vref*, *dB*, *K*, *Qmax*, and *Qmin* are the system parameters to define the volt-var characteristic
- *Tref* is the AARV time constant, which ranges from 300s to 5000s. No default value was provided in IEEE 1547, but 300s works well whenever AARV is enabled.
- *Tresponse* is the open-loop response time, which ranges from 1s to 90s. The default in IEEE 1547 is 10s for category A and 5s for category B.
- *dt* is the time step for simulation and plotting.
- *bShiftTable* is a flag to choose between two different implementations of AARV:
 - *True* means that the V1..V4 points in the volt-var characteristic are shifted each time *Vref* changes. This procedure strictly follows language in the footnote in IEEE 1547-2018, and it performs as intended in simulation. However, it's not efficient and it may lose track of the original settings for V1..V4.
 - *False* means that instead of modifying V1..V4, the voltage used for interpolation is adjusted with an offset to the **original** value of *Vref*, denoted as *Vset* in the code. This method also performs as intended, without regenerating the interpolation table at each time step, and without losing track of the original settings for V1..V4. In the Python function signature, the default value is *False* to indicate that this might be the preferred implementation. (It is also close to the way *OpenDSS* implements AARV).

The function runs for one time constant, *Tref*, and it provides numerical outputs of the peak and final Q. The test procedure ensures that limits on *Vref* will be met, so the function does not check the limits during execution.

1.2.2 Examples of AARV Tests

Run the following Python code cell to simulate three example AARV tests. In each test, the voltage steps to $(V1+V2)/2$. The volt-var characteristic is plotted to the left, and the dynamic response of Q is plotted to the right.

- For default Category A, there is no deadband. The steady-state value of Qs would be 0.125 pu, but Q only reaches 0.1174 pu due to the open-loop response time constant. The value of Q at *Tref* is 0.0467 pu, which is 18.68% of Q1, so this result does not pass the test.
- For default Category B, there is a deadband. The steady-state value of Qs would be 0.22 pu, but Q only reaches 0.2083 pu due to the open-loop response time constant. The value of Q at *Tref* is 0.0, because the voltage has entered the deadband by that time, so this result passes the test.
- For Category B with no deadband and maximum slope (or gain), Q reaches 0.2122, considering the open-loop response time constant along with the higher gain. The final value of Q at *Tref* is 0.0815 pu, which is 18.52%, so this result does not pass the test.



1.2.3 Conclusion

The test in clause 5.14.5 of IEEE 1547.1-2020 is only passed for the default Category B characteristic. Q decreases to 0 at $t=T_{ref}$ because V is within the deadband by that time, and 0 is less than 10% of Q_1 . However, with a deadband, the test fails because Q decreases to about 19% of Q_1 at $t=T_{ref}$. This occurs for the default Category A characteristic, and for a higher-gain Category B characteristic with no deadband. Subgroup 7 should review the test specification for correctness.

AARV should be used without a deadband, so the T_{ref} test procedure should focus on that use case. All three numbered volt-var characteristics in IEEE 1547.1-2020, in Tables 26-28, include a deadband. There should at least be a test characteristic for Category B without a deadband.

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